

MOS FIELD EFFECT TRANSISTOR **2SK3112**

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3112 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, and designed for high voltage applications such as DC/DC converter, actuator driver.

ORDERING INFORMATION

PART NUMBER	PACKAGE			
2SK3112	TO-220AB			
2SK3112-S	TO-262			
2SK3112-ZJ	TO-263(MP-25ZJ)			

FEATURES

- Gate voltage rating ±30 V
- · Low on-state resistance

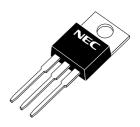
 $R_{DS(on)}$ = 110 m Ω MAX. (V_{GS} = 10 V, I_D = 13 A)

· Low input capacitance

 $C_{iss} = 1600 \text{ pF TYP}. (V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V})$

- · Avalanche capability rated
- · Built-in gate protection diode
- · Surface mount device available

(TO-220AB)



(TO-262)



(TO-263)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Ves = 0 V)	V_{DSS}	200	V
Gate to Source Voltage (V _{DS} = 0 V)	V_{GSS}	±30	V
Drain Current (DC) (Tc = 25°C)	$I_{D(DC)}$	±25	Α
Drain Current (pulse) Note1	$I_{D(pulse)}$	±75	Α
Total Power Dissipation ($T_c = 25^{\circ}C$)	P _{T1}	100	W
Total Power Dissipation ($T_A = 25^{\circ}C$)	P_{T2}	1.5	W
Channel Temperature	T_{ch}	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C
Single Avalanche Current Note2	I _{AS}	25	Α
Single Avalanche Energy Note2	Eas	250	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting $T_{ch} = 25^{\circ}C$, $V_{DD} = 100 \text{ V}$, $R_G = 25 \Omega$, $V_{GS} = 20 \text{ V} \rightarrow 0 \text{ V}$



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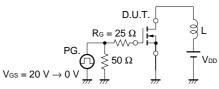
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

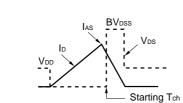


ELECTRICAL CHARACTERISTICS (TA = 25°C)

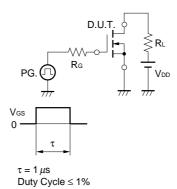
Characteristics	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 200 V, V _{GS} = 0 V			100	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	2.5		4.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 13 A	6.0			S
Drain to Source On-state Resistance	R _{DS(on)}	Vgs = 10 V, ID = 13 A		76	110	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		1600		pF
Output Capacitance	Coss	Vgs = 0 V		430		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		280		pF
Turn-on Delay Time	td(on)	V _{DD} = 100 V , I _D = 13 A		35		ns
Rise Time	tr	Vgs = 10 V		140		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		110		ns
Fall Time	tf			70		ns
Total Gate Charge	Q _G	V _{DD} = 160 V		60		nC
Gate to Source Charge	Qgs	Vgs = 10 V		11		nC
Gate to Drain Charge	Q _{GD}	ID = 25 A		40		nC
Body Diode Forward Voltage	V _{F(S-D)}	I _F = 25 A, V _G s = 0 V		1.0		٧
Reverse Recovery Time	trr	IF = 25 A, VGS = 0 V		300		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A/μs		1.8		μC

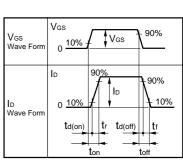
TEST CIRCUIT 1 AVALANCHE CAPABILITY





TEST CIRCUIT 2 SWITCHING TIME

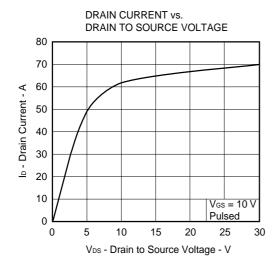


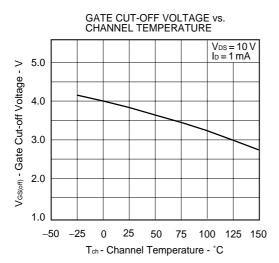


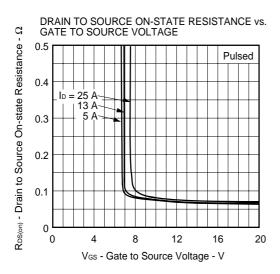
TEST CIRCUIT 3 GATE CHARGE

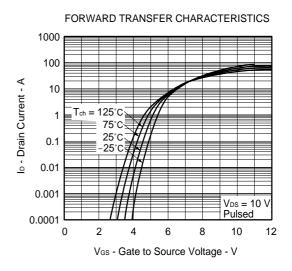


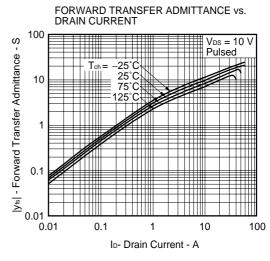
TYPICAL CHARACTERISTICS (TA = 25°C)

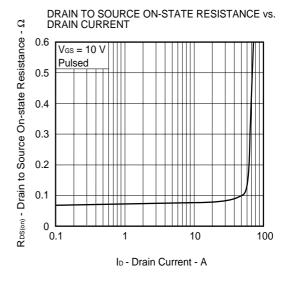


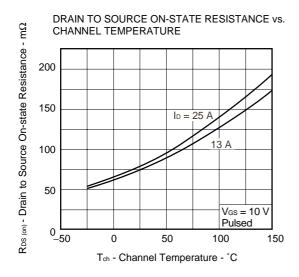


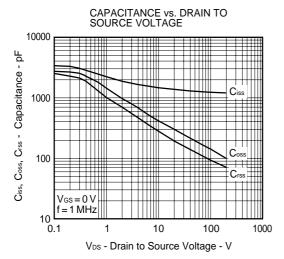


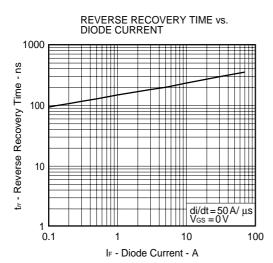


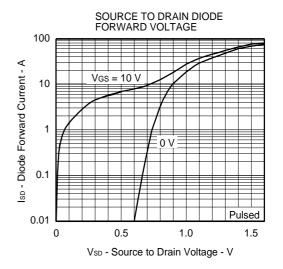


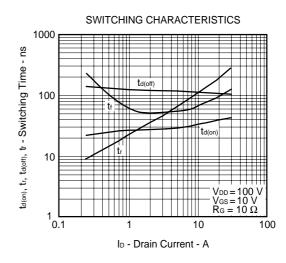


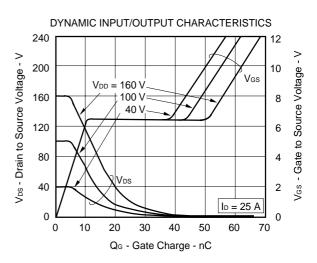








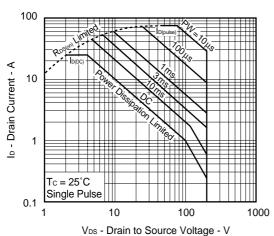




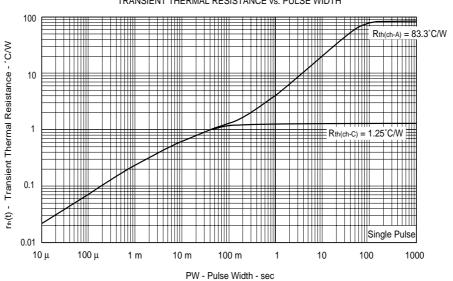
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA dT - Percentage of Rated Power - % 0 L 100 120 Tch - Channel Temperature - °C

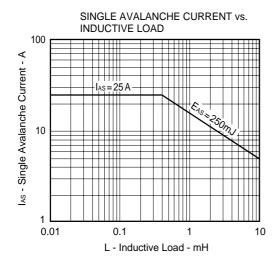
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE P_T - Total Power Dissipation - W Tc - Case Temperature - °C

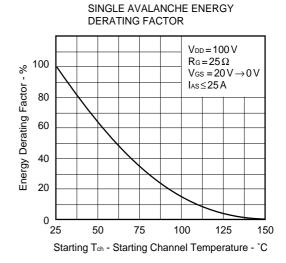
FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



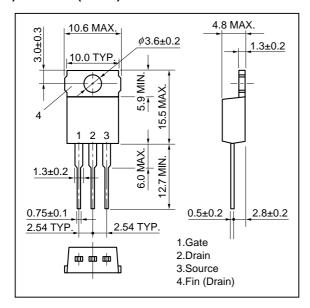




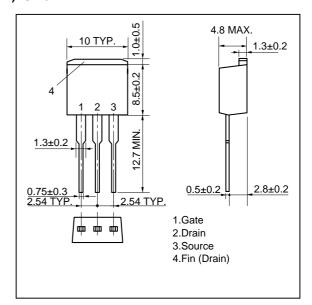


PACKAGE DRAWINGS (Unit: mm)

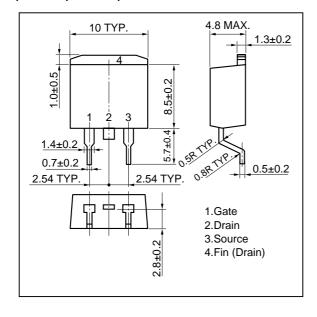
1)TO-220AB (MP-25)



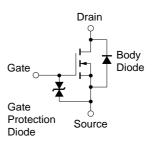
2)TO-262



3)TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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